


<b>Search Notes</b> 	<b>Application/Control No.</b> 10791557	<b>Applicant(s)/Patent Under Reexamination</b> KANIZ ET AL.
	<b>Examiner</b> JASON K GEE	<b>Art Unit</b> 2134

SEARCHED			
Class	Subclass	Date	Examiner
713	176	8/20/2008	JKG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST - US_PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	8/20/2008	JKG
PALM - Inventor Name Search	8/20/2008	JKG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--